

**Search Notes**

Application/Control No.

09/925,734

Examiner

Yixing Qin

Applicant(s)/Patent under  
Reexamination

OKUNISHI ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Performed updated searching for print parameters stored in process cartridges	3/4/2008	YQ